

Notice of References Cited	Application/Control No. 09/834,165	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,411,306	06-2002	Miller et al.	345/690
	B	US-2003/0043299	03-2003	Lee et al.	348/603
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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